

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/565,876	SHIN, HEE-SEOK	
Examiner		Thanh-Tam T. Le	Art Unit	Page 1 of 1
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*	B	US-6,203,345 B1	03-2001	Roque et al.	439/260
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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